

### **IRL610A-VB Datasheet**

N-Channel 200 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	200				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V 0.91				
Q <sub>g</sub> (Max.) (nC)	13				
Q <sub>gs</sub> (nC)	3.0				
Q <sub>gd</sub> (nC)	7.9				
Configuration	Single	)			

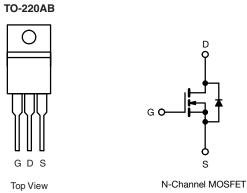
#### **FEATURES**

- TrenchFET<sup>®</sup> Power MOSFET
- 175 °C Junction Temperature
- PWM Optimized
- 100 % R<sub>a</sub> Tested
- Compliant to RoHS Directive 2002/95/EC

#### **APPLICATIONS**

• Primary Side Switch





<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_C =$	= 25 °C, uni	less otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	200	v	
Gate-Source Voltage			V <sub>GS</sub>	± 20		
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	1-	5.0		
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	ID	4.0	А	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	20		
Linear Derating Factor				0.33	W/°C	
Linear Derating Factor (PCB Mount) <sup>e</sup>			1	0.020	W/ C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	161	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	4.8	А	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	4.2	mJ	
Maximum Power Dissipation $T_{\rm C} = 25 ^{\circ}{\rm C}$		D	42	- w		
Maximum Power Dissipation (PCB mount) e	T <sub>A</sub> = 25 °C		P <sub>D</sub> 2.5			
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	5.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150		
Soldering Recommendations (Peak temperature) <sup>d</sup>	for 10 s			260	°C	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 50 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 14 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 4.8 \text{ A}$  (see fig. 12). c.  $I_{SD} \leq 5.2 \text{ A}$ , dI/dt  $\leq 95 \text{ A/}\mu$ s,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq 150 \text{ °C}$ .

d. 1.6 mm from case.

e. When mounted on 1" square PCB (FR-4 or G-10 material).



THERMAL RESISTANCE RAT	IAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	-	110	
Maximum Junction-to-Ambient (PCB mount) <sup>a</sup>	R <sub>thJA</sub>	-	-	50	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	-	3.0	

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static		-					<b>I</b>
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub>	= 0 V, I <sub>D</sub> = 250 μΑ	200	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	ce to 25 °C, I <sub>D</sub> = 1 mA	-	0.29	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μΑ	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		= 200 V, V <sub>GS</sub> = 0 V /, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	25 250	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 2.9 A <sup>b</sup>	-	0.91	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	50 V, I <sub>D</sub> = 2.9 A <sup>b</sup>	1.7	-	-	S
Dynamic		-					1
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 V,$		-	185	-	pF
Output Capacitance	Coss		$V_{\rm GS} = 0.V,$ $V_{\rm DS} = 25 V,$		100	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1	.0 MHz, see fig. 5	-	30	-	
Total Gate Charge	Qg			-	-	13.0	
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 V$	I <sub>D</sub> = 4.8 A, V <sub>DS</sub> = 160 V, see fig. 6 and 13 <sup>b</sup>	-	-	3.0	nC
Gate-Drain Charge	Q <sub>gd</sub>				7.9	1	
Turn-On Delay Time	t <sub>d(on)</sub>			-	7.2	-	
Rise Time	t <sub>r</sub>	V <sub>DD</sub> =	= 100 V, I <sub>D</sub> = 4.8 A,	-	22	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	R <sub>G</sub> = 18 Ω,	$R_D = 20 \Omega$ , see fig. 10 <sup>b</sup>	-	19	-	ns
Fall Time	t <sub>f</sub>		- 13		-	1	
Internal Drain Inductance	L <sub>D</sub>	( /	from	-	4.5	-	
Internal Source Inductance	L <sub>S</sub>	6 mm (0.25") from package and center of		-	nH		
Drain-Source Body Diode Characteristic	s	•					•
Continuous Source-Drain Diode Current	I <sub>S</sub>	showing the	MOSFET symbol showing the		-	4.8	^
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral revers p - n junction		-	-	19	A
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C	, $I_{S} = 4.8$ A, $V_{GS} = 0$ V <sup>b</sup>	-	-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T 05 %C 1	4.9.4 dl/d+ 100.4/ h	-	150	300	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$I_{\rm J} = 25  {}^{-}{\rm C}, I_{\rm F}$	= 4.8 A, dl/dt = 100 A/µs <sup>b</sup>	-	0.91	1.8	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	ırn-on time is negligible (turn	-on is dor	ninated b	y L <sub>S</sub> and	L <sub>D</sub> )

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

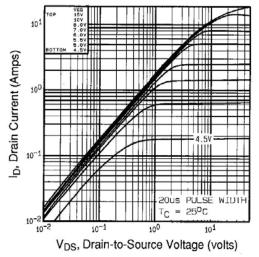


Fig. 1 - Typical Output Characteristics,  $T_C = 25 \ ^{\circ}C$ 

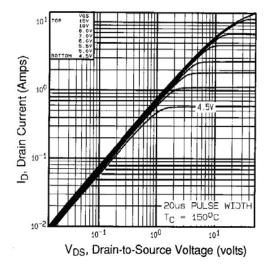


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C

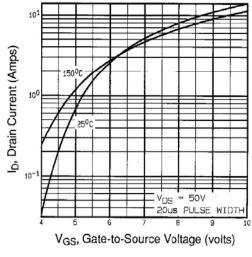


Fig. 3 - Typical Transfer Characteristics

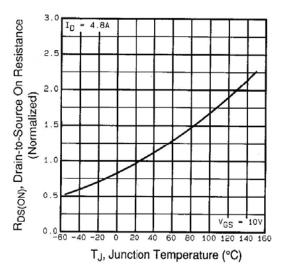


Fig. 4 - Normalized On-Resistance vs. Temperature



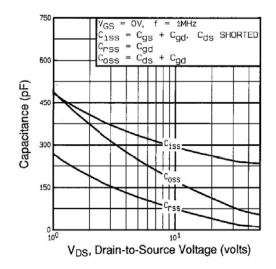


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

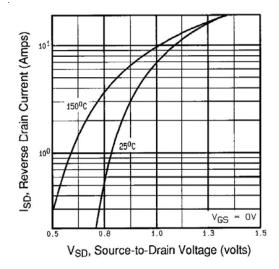


Fig. 7 - Typical Source-Drain Diode Forward Voltage

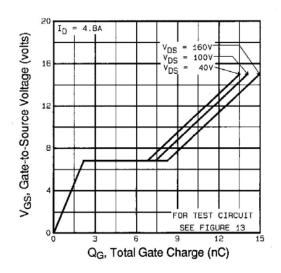


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

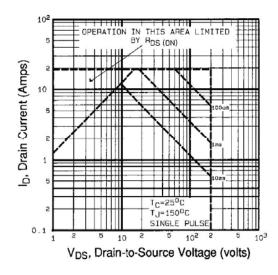


Fig. 8 - Maximum Safe Operating Area



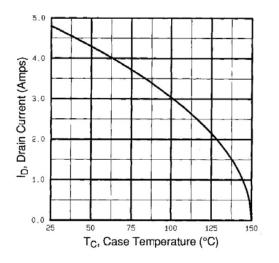


Fig. 9 - Maximum Drain Current vs. Case Temperature

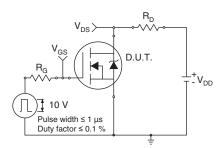


Fig. 10a - Switching Time Test Circuit

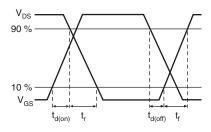


Fig. 10b - Switching Time Waveforms

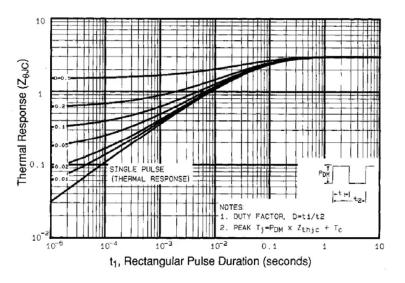


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



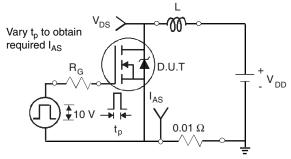


Fig. 12a - Unclamped Inductive Test Circuit

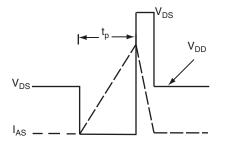


Fig. 12b - Unclamped Inductive Waveforms

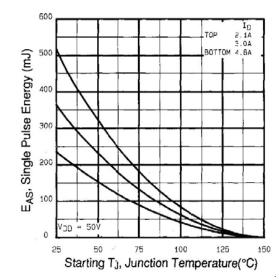


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

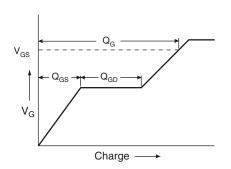


Fig. 13a - Basic Gate Charge Waveform

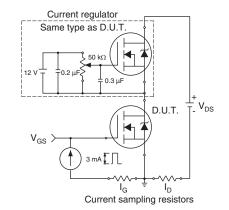
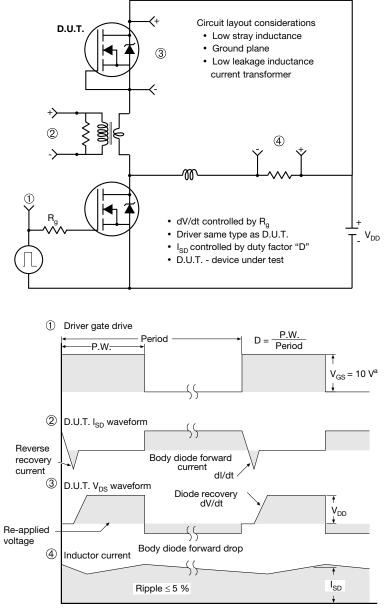


Fig. 13b - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



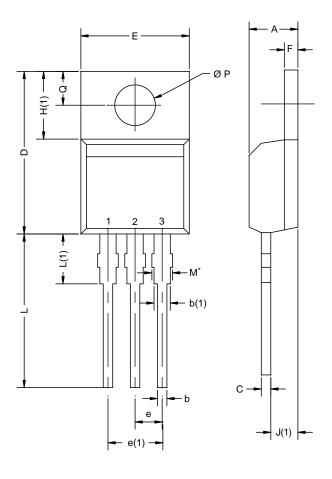
Note

a.  $V_{GS}$  = 5 V for logic level devices

Fig. 14 - For N-Channel



## **TO-220AB**



	MILLIN	IETERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	4.25	4.65	0.167	0.183
b	0.69	1.01	0.027	0.040
b(1)	1.20	1.73	0.047	0.068
С	0.36	0.61	0.014	0.024
D	14.85	15.49	0.585	0.610
E	10.04	10.51	0.395	0.414
е	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.09	6.48	0.240	0.255
J(1)	2.41	2.92	0.095	0.115
L	13.35	14.02	0.526	0.552
L(1)	3.32	3.82	0.131	0.150
ØР	3.54	3.94	0.139	0.155
Q	2.60	3.00	0.102	0.118
ECN: X12- DWG: 547	0208-Rev. N, 1	08-Oct-12		

#### Notes

 $^{\star}$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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